FORM PTO 1449 (modified)

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)

Submitted to the PTO: February 2, 2004

ATTY DOCKET NO. 03560.002897.1 APPLICATION NO.

To be assign d

APPLICANTS KOHEI NAKATA, ET AL.

FILING DATE

February 2, 2004

GROUP 2831

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^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

SDM\mm DC_MAIN 154238v1 Sheet 1 of 1